



Preliminary Data

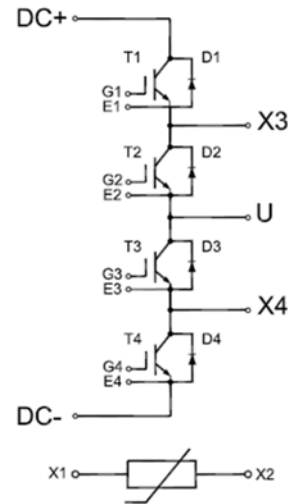
Features:

- Field Stop Trench Gate IGBT
- Short Circuit Rated $>10\mu\text{s}$
- Low Saturation Voltage
- Low Switching Loss
- 100% RBSOA Tested($2\times I_c$)
- Lead Free, Compliant with RoHS Requirement

Applications:

- 3-Level-Applications
- Solar Applications

Circuit Diagram



IGBT, Buck Switch (T1, T4)

Maximum Rated Values (T_C=25°C unless otherwise specified)

Symbol	Description		Values	Units
V _{CES}	Collector-Emitter Blocking Voltage		1200	V
V _{GES}	Gate-Emitter Voltage		±20	V
I _C	Continuous Collector Current	T _C =100°C	300	A
		T _C =25°C	600	A
I _{CM}	Peak Collector Current Repetitive	t _p =1ms	600	A
P _D	Maximum Power Dissipation (per IGBT)	T _C =25°C T _{Jmax} =175°C	3000	W



Electrical Characteristics of IGBT ($T_C=25^\circ\text{C}$ unless otherwise specified)

Static Characteristics

Symbol	Description	Conditions	Min.	Typ.	Max.	Units
$V_{GE(th)}$	Gate-Emitter Threshold Voltage	$I_C=3.8\text{mA}$, $V_{CE}=V_{GE}$	5.0	5.7	6.5	V
$V_{CE(sat)}$	Collector-Emitter Saturation Voltage	$I_C=300\text{A}$, $V_{GE}=15\text{V}$	$T_J=25^\circ\text{C}$	1.65	2.10	V
			$T_J=125^\circ\text{C}$	2.00		V
			$T_J=150^\circ\text{C}$	2.10		V
I_{CES}	Collector-Emitter Leakage Current	$V_{GE}=0\text{V}$, $V_{CE}=V_{CES}$, $T_J=25^\circ\text{C}$			1	mA
I_{GES}	Gate-Emitter Leakage Current	$V_{GE}=\pm 20\text{V}$, $V_{CE}=0\text{V}$, $T_J=25^\circ\text{C}$			± 200	nA
C_{ies}	Input Capacitance	$V_{CE}=25\text{V}$, $V_{GE}=0\text{V}$, $f=100\text{kHz}$		34.39		nF
C_{oes}	Output Capacitance			4.57		nF
C_{res}	Reverse Transfer Capacitance			2.21		nF

Switching Characteristics

$t_{d(on)}$	Turn-on Delay Time	$V_{CC}=600V, I_C=300A,$ $R_{Gon}=0.33\Omega, V_{GE}=\pm 15V,$ Inductive Load	$T_J=25^{\circ}C$		259		ns
			$T_J=125^{\circ}C$		278		
			$T_J=150^{\circ}C$		290		
t_r	Rise Time		$T_J=25^{\circ}C$		125		ns
			$T_J=125^{\circ}C$		134		
			$T_J=150^{\circ}C$		136		
$t_{d(off)}$	Turn-off Delay Time		$T_J=25^{\circ}C$		230		ns
			$T_J=125^{\circ}C$		236		
			$T_J=150^{\circ}C$		236		
t_f	Fall Time	$T_J=25^{\circ}C$		170		ns	
		$T_J=125^{\circ}C$		223			
		$T_J=150^{\circ}C$		232			
E_{on}	Turn-on Switching Loss	$V_{CC}=600V, I_C=300A,$ $R_{Gon}=0.33\Omega, V_{GE}=\pm 15V,$ $di/dt=2261A/\mu s$ ($T_J=150^{\circ}C$), Inductive Load	$T_J=25^{\circ}C$		8.1		mJ
		$T_J=125^{\circ}C$		14.1			
		$T_J=150^{\circ}C$		16.9			



E _{off}	Turn-off Switching Loss	V _{CC} =600V, I _C =300A, R _{Goff} =0.33Ω, V _{GE} =±15V, du/dt=6675V/μs (T _J =150℃), Inductive Load	T _J =25℃		23.5		mJ
			T _J =125℃		30.5		
			T _J =150℃		32.4		
Q _g	Total Gate Charge		T _J =25℃		8.73		μC
R _{G(int)}	Internal Gate Resistor		T _J =25℃		1.83		Ω
SCSOA	V _{CC} =600V, V _{GE} =±15V,t _p =10μs, T _J =150℃, R _G =15Ω				1320		A
R _{θJC}	Thermal Resistance: Junction-to-Case (per IGBT)					0.05	℃/W

Buck Diode (D2, D3)

Maximum Rated Values(T_C=25°Cunless otherwise specified)

V _{RRM}	Repetitive Peak Reverse Voltage	T _J =25°C	1200	V
I _F	Continuous Forward Current	T _C =100°C	300	A
I _{FM}	Maximum Forward Current	t _p =1ms	600	A

Electrical Characteristics of Diode (T_C=25°Cunless otherwise specified)

Symbol	Description	Conditions		Min.	Typ.	Max.	Units
V _{FM}	Forward Voltage	I _F =300A	T _J =25℃		1.65		V
			T _J =125℃		1.80		
			T _J =150℃		1.80		
t _{rr}	Reverse Recovery Time	I _F =300A, -diF/dt=1950A/μs(T _J =150℃), V _{rr} =600V, V _{GE} =-15V	T _J =25℃		138		ns
			T _J =125℃		182		
			T _J =150℃		212		
I _{rr}	Peak Reverse Recovery Current		T _J =25℃		408		A
			T _J =125℃		465		
			T _J =150℃		477		
Q _{rr}	Reverse Recovery Charge		T _J =25℃		31.8		μC
			T _J =125℃		46.2		
			T _J =150℃		52.5		



E _{rec}	Reverse Recovery Energy	I _F =300A, -diF/dt=1950A/μs(T _J =150°C), V _{rr} =600V, V _{GE} =-15V	T _J =25°C		15.0		mJ
			T _J =125°C		20.0		
			T _J =150°C		22.8		
R _{θJC}	Thermal Resistance: Junction-to-Case (per Diode)					0.08	°C/W

IGBT, Boost Switch (T2, T3)

Maximum Rated Values(T_C=25°Cunless otherwise specified)

Symbol	Description		Values	Units
V _{CES}	Collector-Emitter Blocking Voltage		1200	V
V _{GES}	Gate-Emitter Voltage		±20	V
I _C	Continuous Collector Current	T _C =100°C	300	A
		T _C =25°C	600	A
I _{CM}	Peak Collector Current Repetitive	t _p =1ms	600	A
P _D	Maximum Power Dissipation (per IGBT)	T _C =25°C T _{Jmax} =175°C	3000	W

Electrical Characteristics of IGBT (T_C=25°Cunless otherwise specified)

Static Characteristics

Symbol	Description	Conditions		Min.	Typ.	Max.	Units
V _{GE(th)}	Gate-Emitter Threshold Voltage	I _C =3.8mA, V _{CE} =V _{GE}		5.0	5.7	6.5	V
V _{CE(sat)}	Collector-Emitter Saturation Voltage	I _C =300A, V _{GE} =15V	T _J =25°C		1.65	2.10	V
			T _J =125°C		2.00		V
			T _J =150°C		2.10		V
I _{CES}	Collector-Emitter Leakage Current	V _{GE} =0V, V _{CE} =V _{CES} , T _J =25°C				1	mA
I _{GES}	Gate-Emitter Leakage Current	V _{GE} =±20V, V _{CE} =0V, T _J =25°C				±200	nA
C _{ies}	Input Capacitance	V _{CE} =25V, V _{GE} =0V, f=100kHz			34.39		nF
C _{oes}	Output Capacitance				4.57		nF
C _{res}	Reverse Transfer Capacitance				2.21		nF



Switching Characteristics

t _{d(on)}	Turn-on Delay Time	V _{CC} =600V, I _C =300A, R _{Gon} =0.33Ω, V _{GE} =±15V, Inductive Load	T _J =25℃		259		ns
			T _J =125℃		278		
			T _J =150℃		290		
t _r	Rise Time		T _J =25℃		125		ns
			T _J =125℃		134		
			T _J =150℃		136		
t _{d(off)}	Turn-off Delay Time	V _{CC} =600V, I _C =300A, R _{Goff} =0.33Ω, V _{GE} =±15V, Inductive Load	T _J =25℃		230		ns
			T _J =125℃		236		
			T _J =150℃		236		
t _f	Fall Time		T _J =25℃		170		ns
			T _J =125℃		223		
			T _J =150℃		232		
E _{on}	Turn-on Switching Loss	V _{CC} =600V, I _C =300A, R _{Gon} =0.33Ω, V _{GE} =±15V, di/dt=2261A/μs (T _J =150℃), Inductive Load	T _J =25℃		8.1		mJ
			T _J =125℃		14.1		
			T _J =150℃		16.9		
E _{off}	Turn-off Switching Loss	V _{CC} =600V, I _C =300A, R _{Goff} =0.33Ω, V _{GE} =±15V, du/dt=6675V/μs (T _J =150℃), Inductive Load	T _J =25℃		23.5		mJ
			T _J =125℃		30.5		
			T _J =150℃		32.4		
Q _g	Total Gate Charge		T _J =25℃		8.73		μC
R _g	Internal Gate Resistor		T _J =25℃		1.83		Ω
SCSOA	V _{CC} =600V, V _{GE} =±15V,t _p =10μs, T _J =150℃, R _G =15Ω				1320		A
R _{θJC}	Thermal Resistance: Junction-to-Case (per IGBT)					0.05	℃/W



Boost Diode (D1, D4)

Maximum Rated Values($T_C=25^{\circ}\text{C}$ unless otherwise specified)

V_{RRM}	Repetitive Peak Reverse Voltage	$T_J=25^{\circ}\text{C}$	1200	V
I_F	Continuous Forward Current	$T_C=100^{\circ}\text{C}$	300	A
I_{FM}	Maximum Forward Current	$t_p=1\text{ms}$	600	A

Electrical Characteristics of Diode ($T_C=25^{\circ}\text{C}$ unless otherwise specified)

Symbol	Description	Conditions		Min.	Typ.	Max.	Units
V _{FM}	Forward Voltage	I _F =300A	T _J =25℃		1.65		V
			T _J =125℃		1.80		
			T _J =150℃		1.80		
t _{rr}	Reverse Recovery Time	I _F =300A, -diF/dt=1950A/μs(T _J =150℃), V _{rr} =600V, V _{GE} =-15V	T _J =25℃		138		ns
			T _J =125℃		182		
			T _J =150℃		212		
I _{rr}	Peak Reverse Recovery Current		T _J =25℃		408		A
			T _J =125℃		465		
			T _J =150℃		477		
Q _{rr}	Reverse Recovery Charge		T _J =25℃		31.8		μC
			T _J =125℃		46.2		
			T _J =150℃		52.5		
E _{rec}	Reverse Recovery Energy		T _J =25℃		15.0		mJ
			T _J =125℃		20.0		
			T _J =150℃		22.8		
R _{θJC}	Thermal Resistance: Junction-to-Case (per Diode)					0.08	℃/W



Internal NTC-Thermistor Characteristics

Symbol	Conditions	Min.	Max.	Units
R_{25}	$T_C=25^{\circ}\text{C}$	5		$\text{k}\Omega$
$\Delta R/R$	$T_C=100^{\circ}\text{C}, R_{100}=465\Omega$		± 5	%
P_{25}	$T_C=25^{\circ}\text{C}$	10		mW
$B_{25/50}$	$R_2=R_{25} \exp[B_{25/50}(1/T_2-1/(298.15\text{K}))]$	3380		K
$B_{25/80}$	$R_2=R_{25} \exp[B_{25/80}(1/T_2-1/(298.15\text{K}))]$	3440		K
$B_{25/100}$	$R_2=R_{25} \exp[B_{25/100}(1/T_2-1/(298.15\text{K}))]$	3545		K

Module

Symbol	Description		Min.	Typ.	Max.	Units
V_{IOS}	Isolation Voltage(All Terminals Shorted)	AC, 50Hz, 30s	4500			V
d_{creep}	Creepage Distance: Terminal to Heatsink			11.2		mm
	Creepage Distance: Terminal to Terminal			6.8		
d_{clear}	Clearance: Terminal to Heatsink			9.4		mm
	Clearance: Terminal to Terminal			5.5		
L_{SCE}	Stray Inductance Module			12		nH
T_J	Maximum Junction Temperature				175	$^{\circ}\text{C}$
T_{JOP}	Maximum Operating Junction Temperature Range		-40		+150	$^{\circ}\text{C}$
T_{stg}	Storage Temperature		-40		+150	$^{\circ}\text{C}$
CTI	Comparative Tracking Index		400			
$R_{\theta CS}$	Case-to-Sink Thermally (Conductive Grease Applied)				0.02	$^{\circ}\text{C/W}$
T	Mounting Screw:M5		2.5		4.0	N·m
G	Weight			162		g



Ordering Information Table

Device code

G	T	300	BB	120	P4	H
①	②	③	④	⑤	⑥	⑦

- ① - IGBT Module
- ② - Trench, Low Switching Losses IGBT
- ③ - Rated Current (300=300A)
- ④ - Circuit Configuration (Buck-Boost)
- ⑤ - Rated Voltage (120=1200V)
- ⑥ - Package Type
- ⑦ - Test Level (Pass the Important Reliability Test-Industrial Grade)

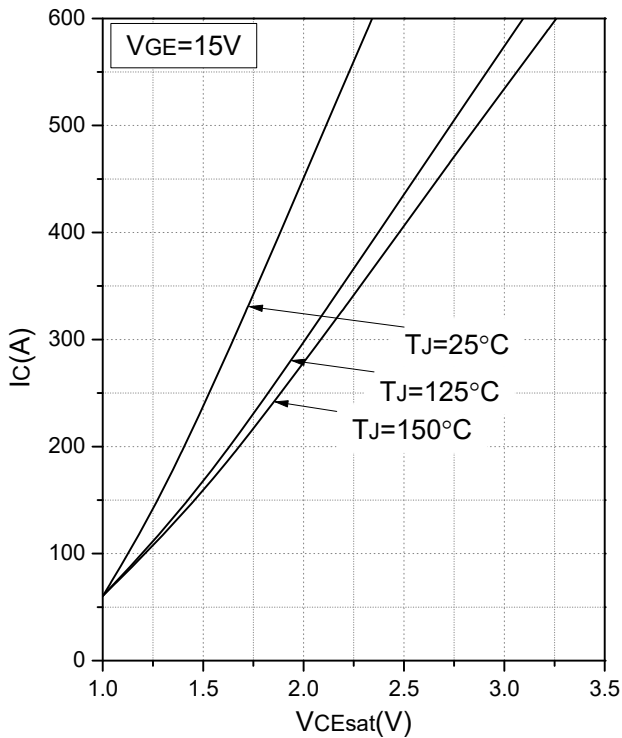


Fig.1 Typical Saturation Voltage Characteristics (Buck Switch(T1,T4))

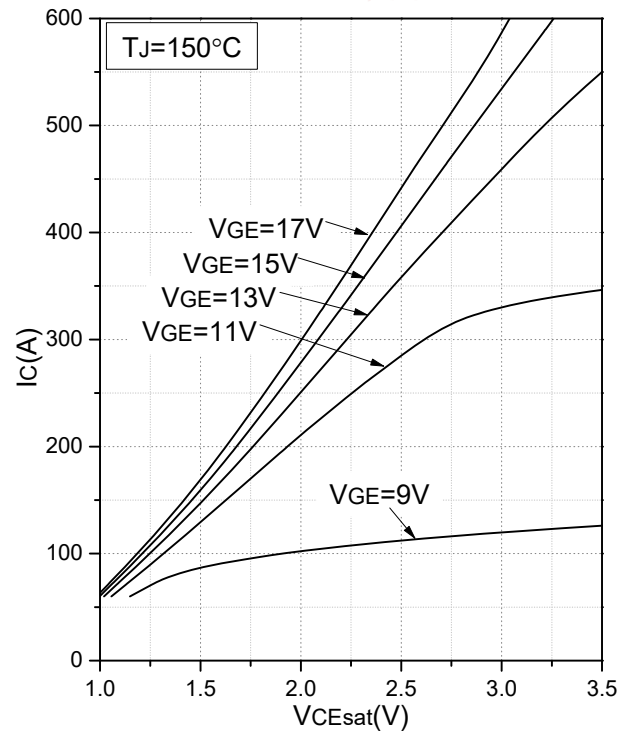


Fig.2 Typical Output Characteristics (Buck Switch(T1,T4))

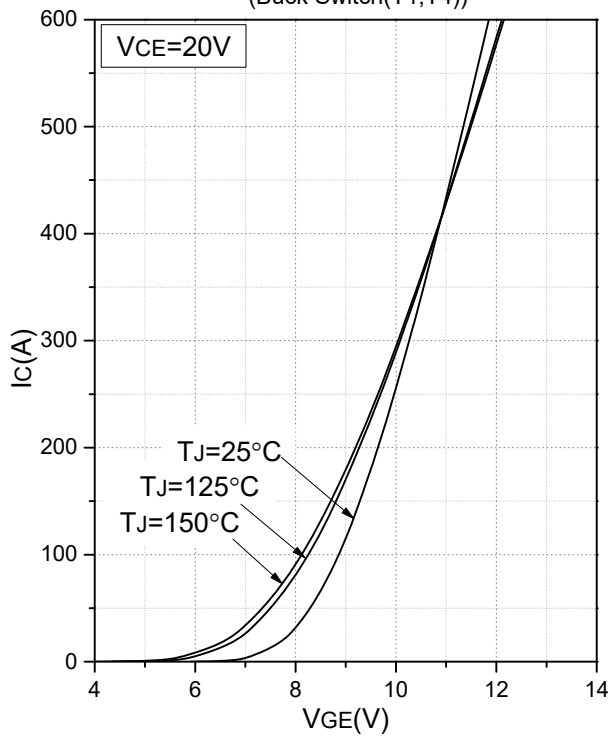


Fig.3 Transfer Characteristic (Buck Switch(T1,T4))

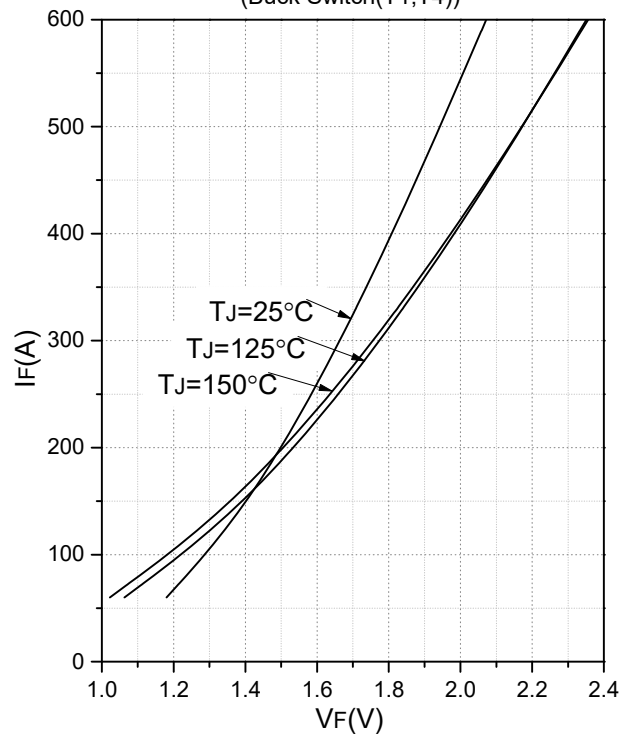


Fig.4 Forward Characteristics of Diode (Buck Diode(D2,D3))

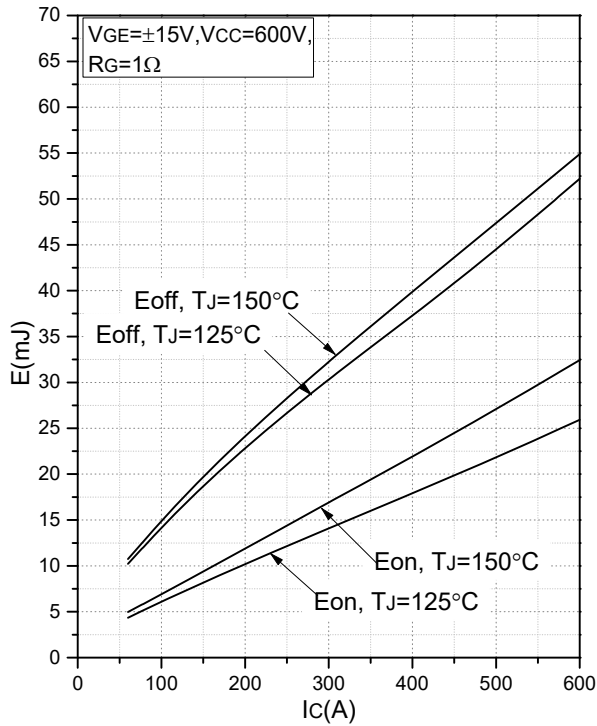


Fig.5 Typical Switching Loss vs. Collector Current (Buck Switch(T1,T4))

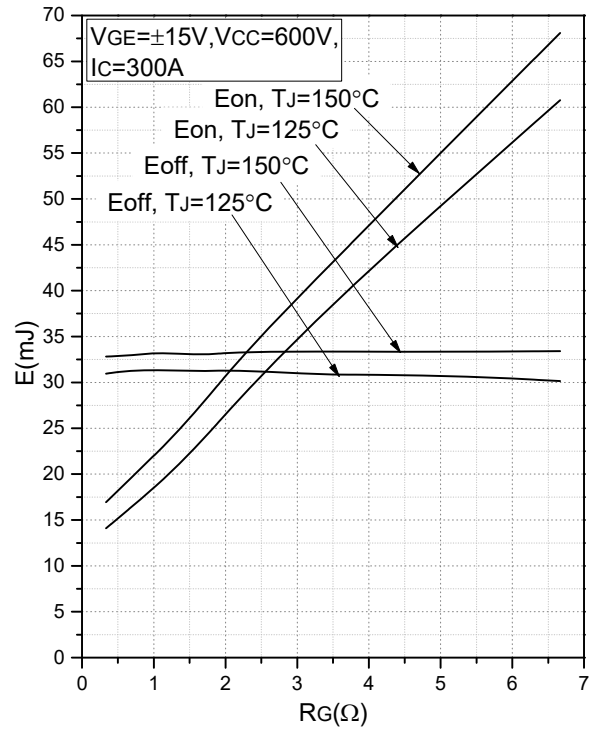


Fig.6 Typical Switching Loss vs. Gate Resistance (Buck Switch(T1,T4))

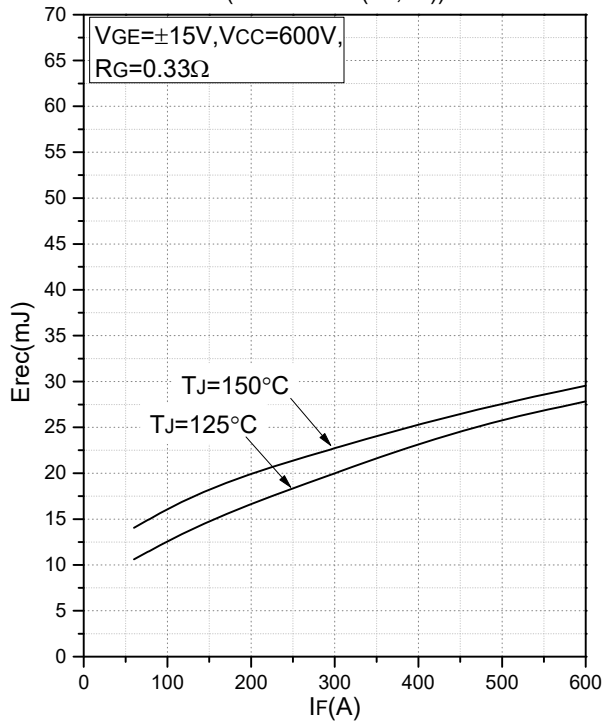


Fig.7 Typical Switching Loss vs. Forward Current (Buck Diode(D2,D3))

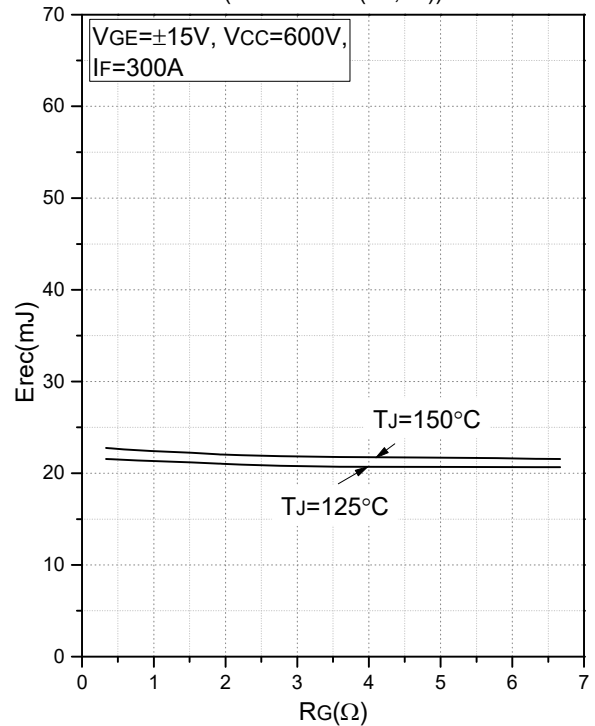


Fig.8 Typical Switching Loss vs. Gate Resistance (Buck Diode(D2,D3))

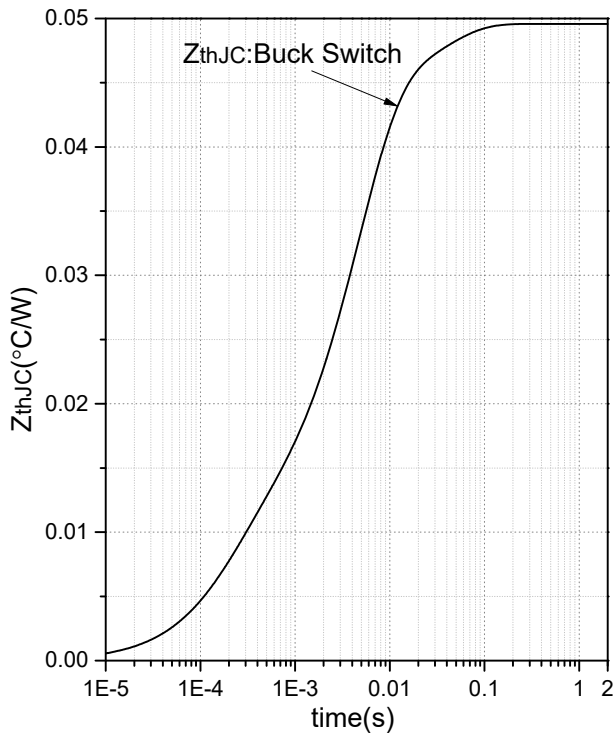


Fig.9 Transient Thermal Impedance
(Buck Switch(T1,T4))

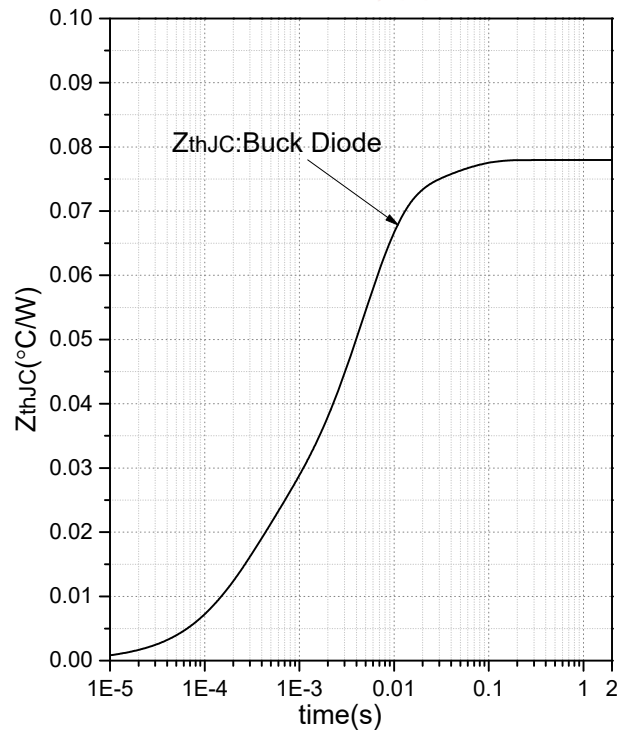


Fig.10 Transient Thermal Impedance
(Buck Diode(D2,D3))

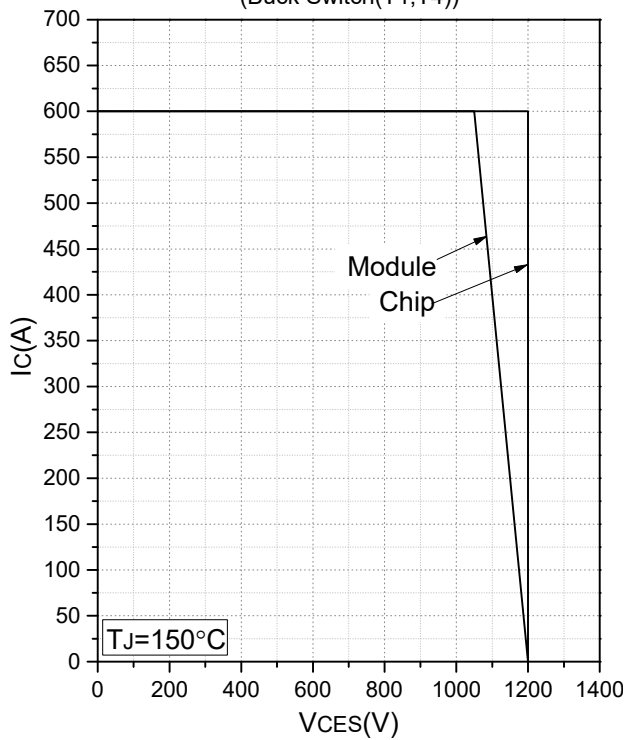


Fig.11 Reverse Bias Safe Operation Area
(Buck Switch(T1,T4))

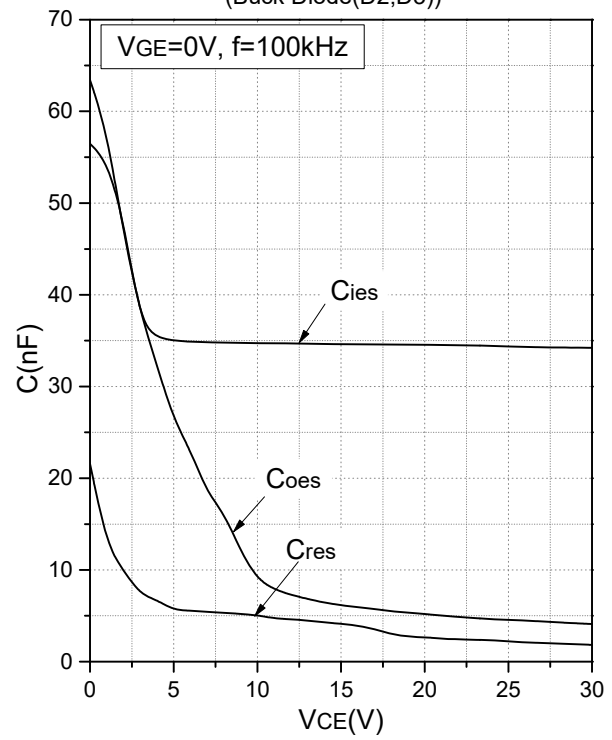


Fig.12 Capacitance Characteristics
(Buck Switch(T1,T4))

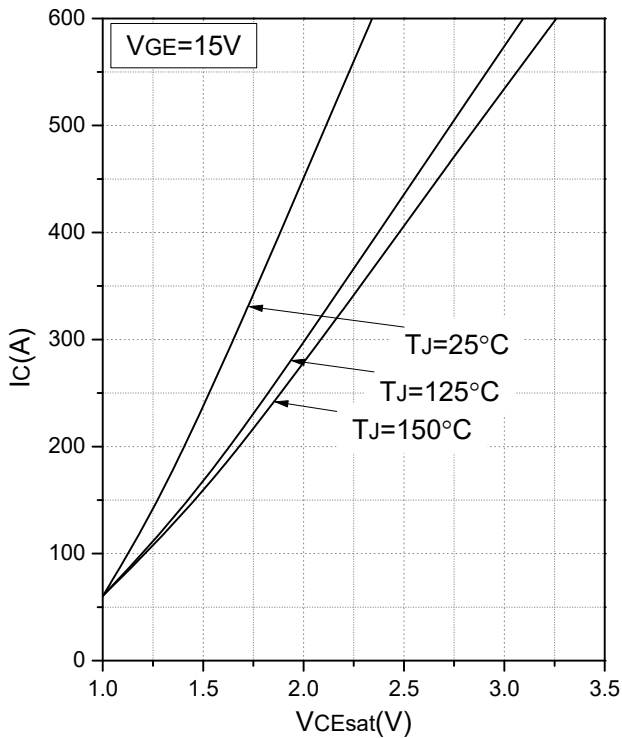


Fig. 13 Typical Saturation Voltage Characteristics (Boost Switch(T2,T3))

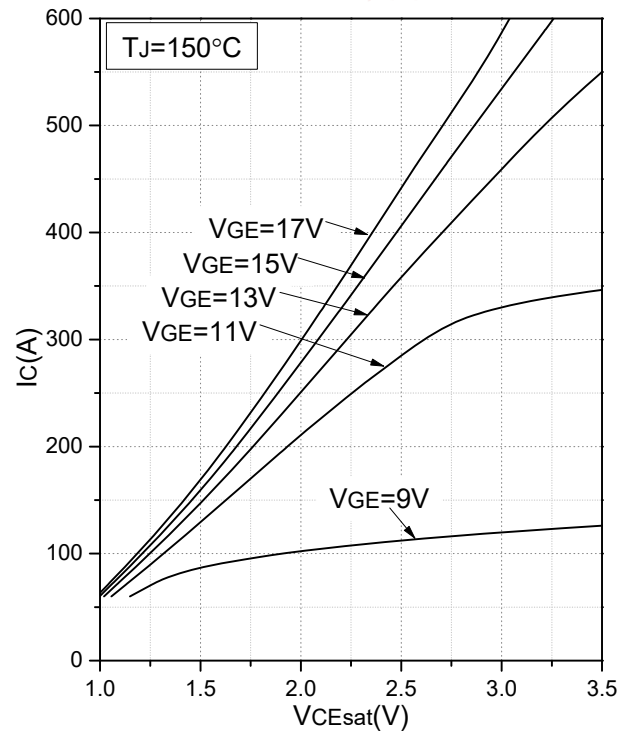


Fig. 14 Typical Output Characteristics (Boost Switch(T2,T3))

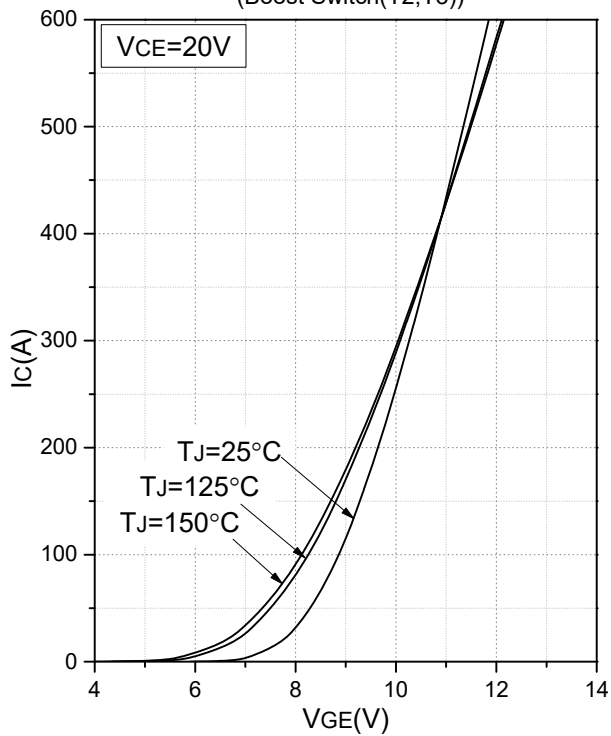


Fig. 15 Transfer Characteristic (Boost Switch(T2,T3))

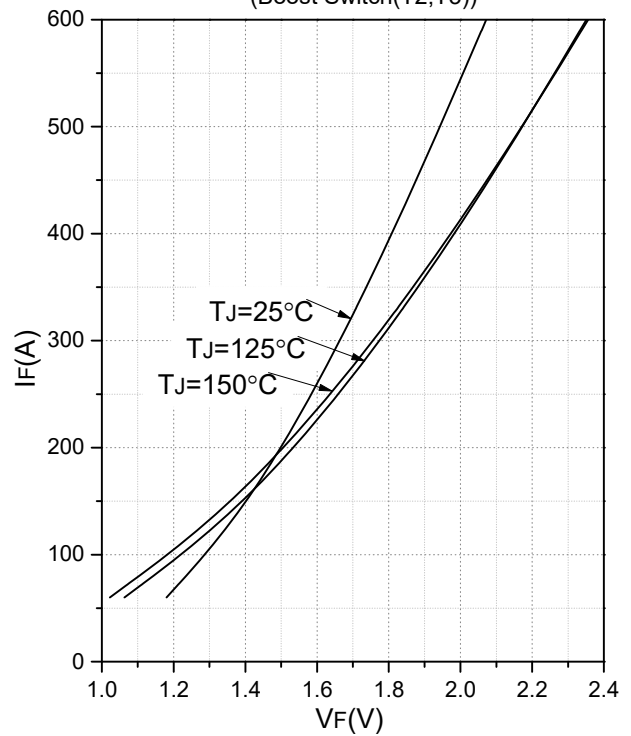


Fig. 16 Forward Characteristics of Diode (Boost Diode(D1,D4))

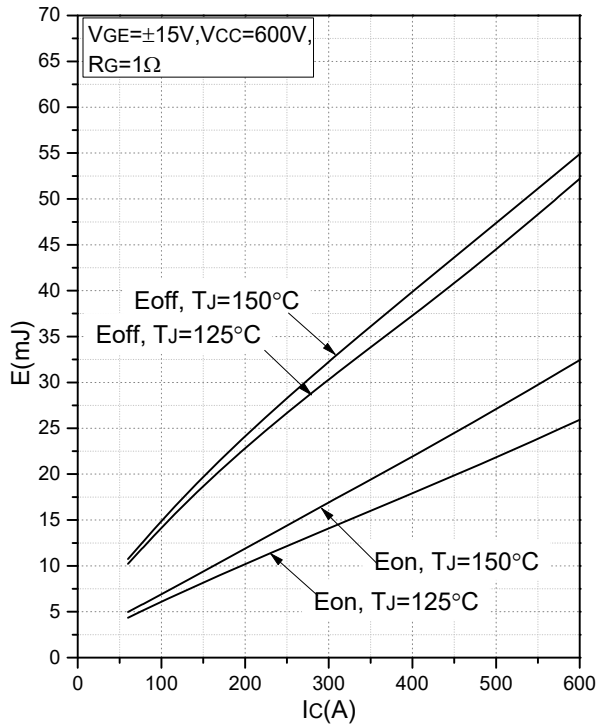


Fig.17 Typical Switching Loss vs. Collector Current (Boost Switch(T2,T3))

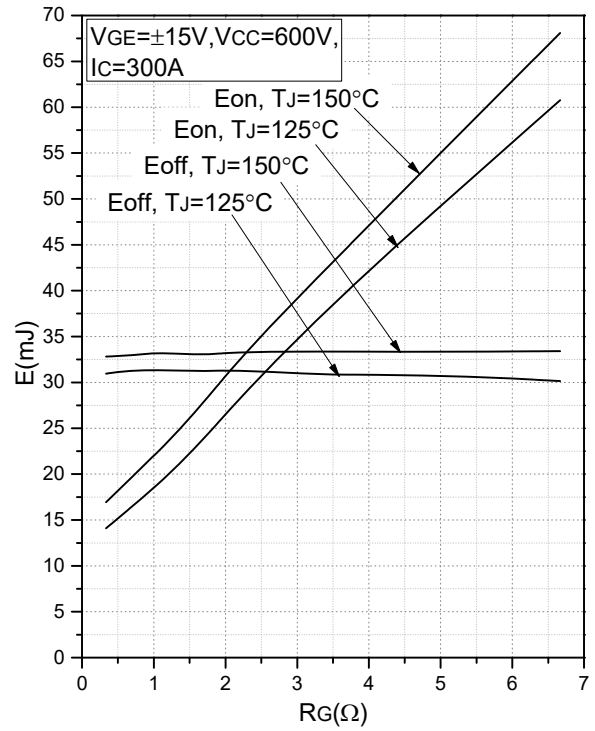


Fig.18 Typical Switching Loss vs. Gate Resistance (Boost Switch(T2,T3))

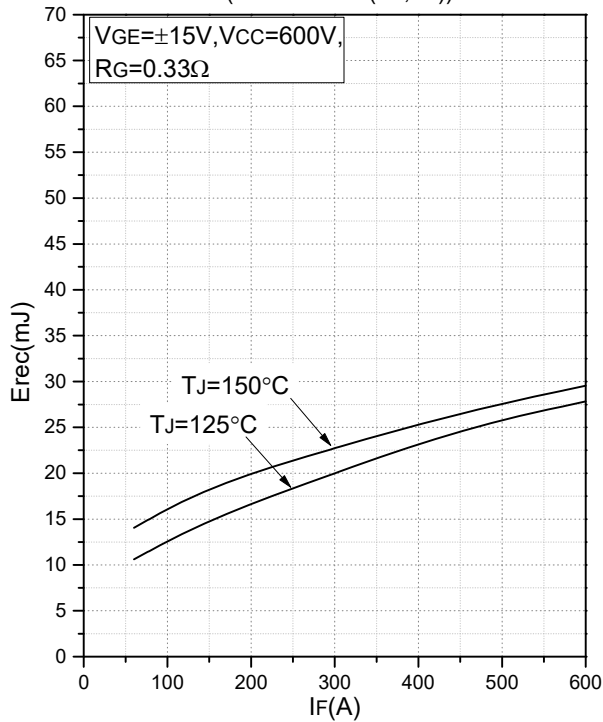


Fig.19 Typical Switching Loss vs. Forward Current (Boost Diode(D1,D4))

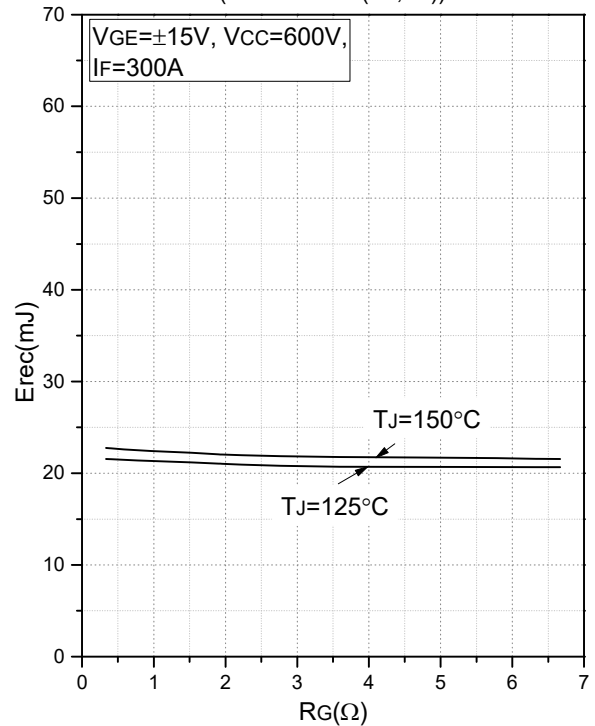


Fig.20 Typical Switching Loss vs. Gate Resistance (Boost Diode(D1,D4))

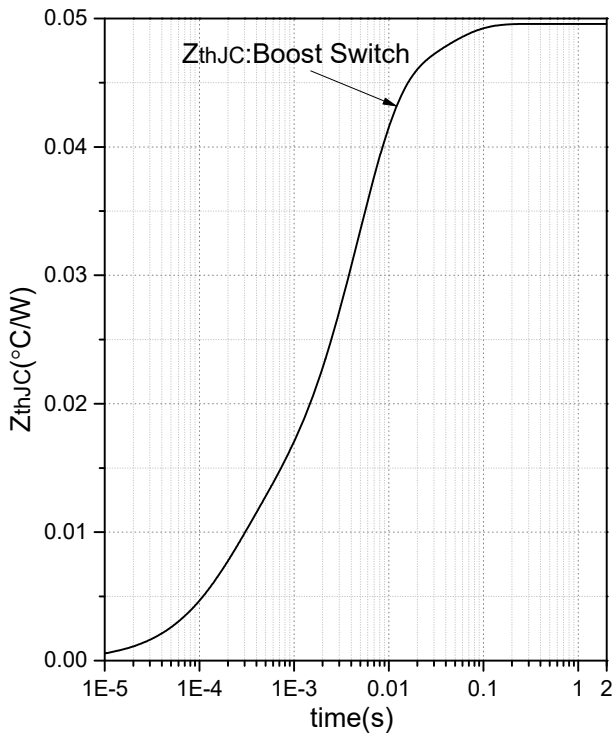


Fig.21 Transient Thermal Impedance
(Boost Switch(T2,T3))

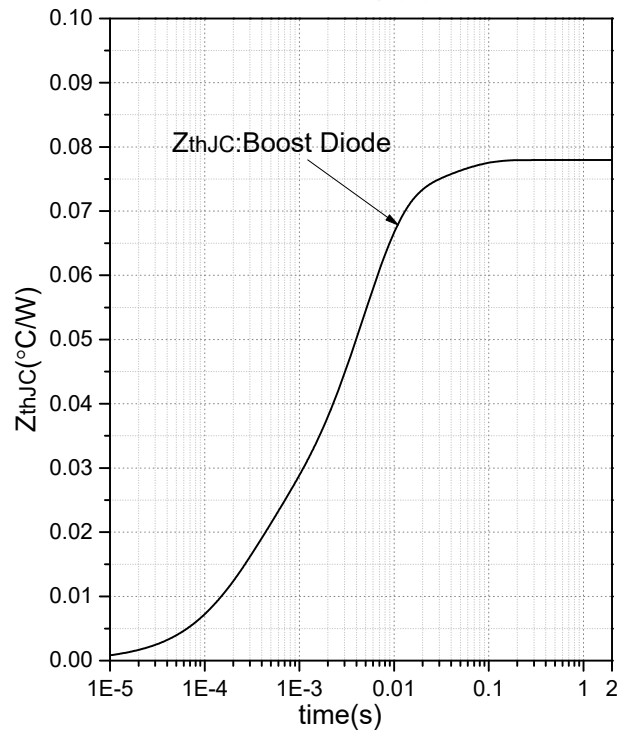


Fig.22 Transient Thermal Impedance
(Boost Diode(D1,D4))

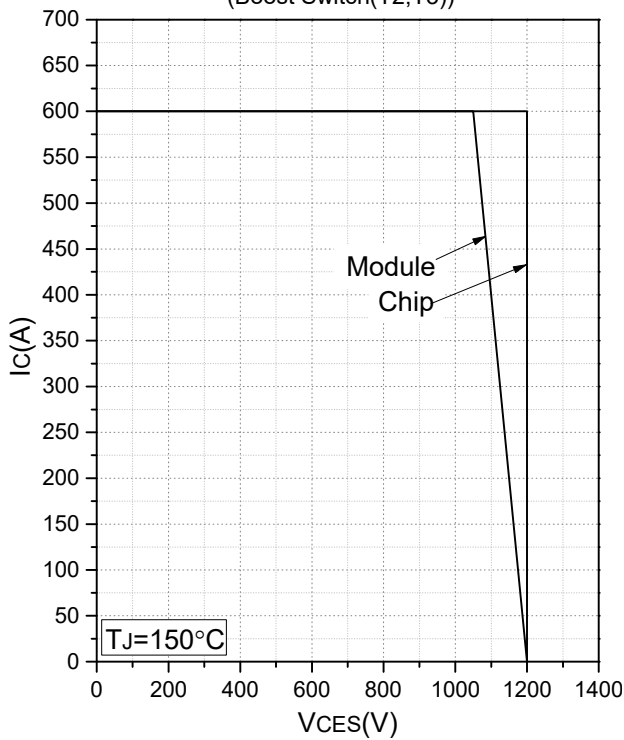


Fig.23 Reverse Bias Safe Operation Area
(Boost Switch(T2,T3))

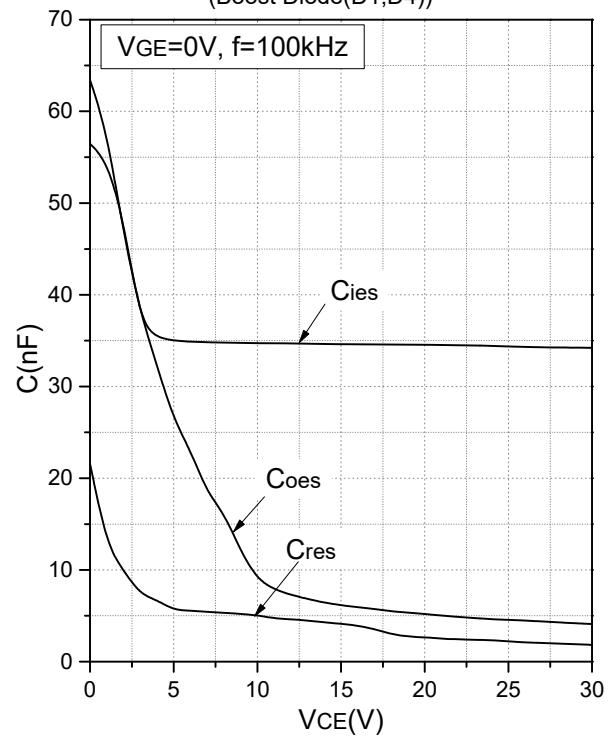


Fig.24 Capacitance Characteristics
(Boost Switch(T2,T3))

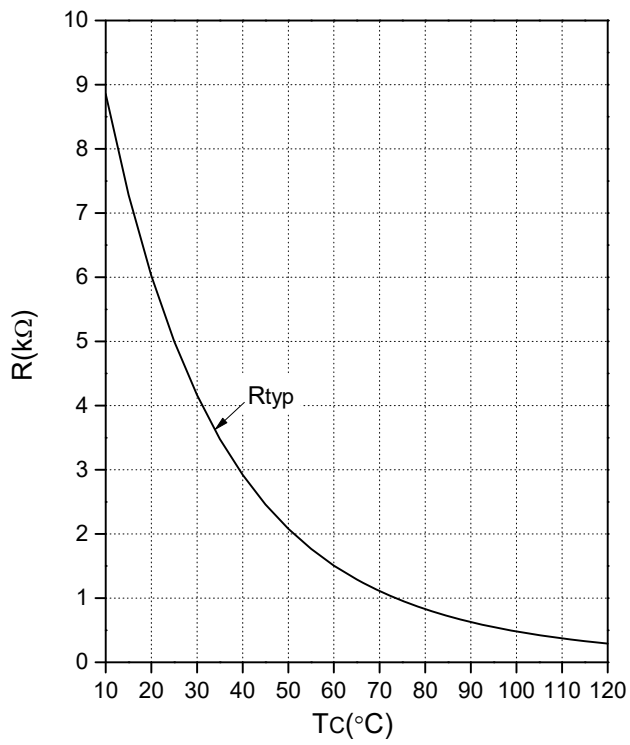
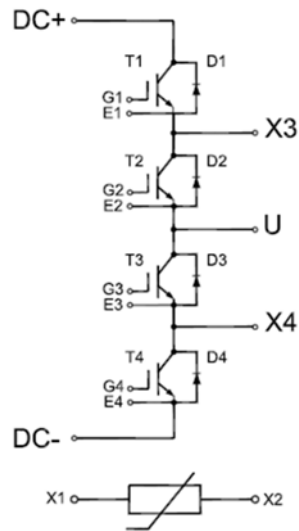


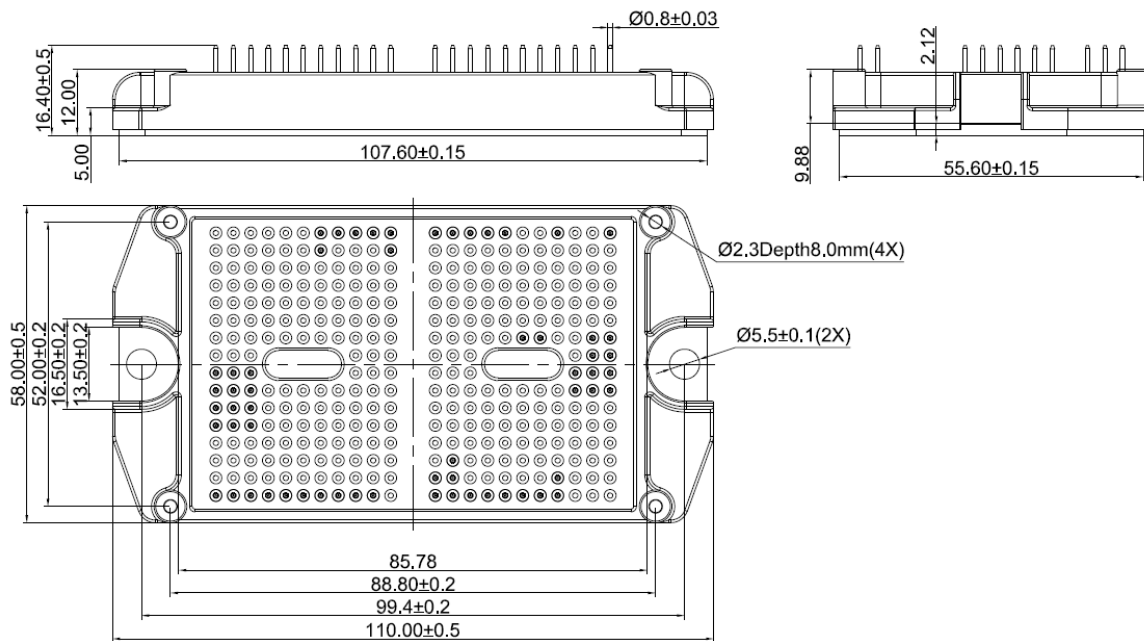
Fig.25 NTC Temperature Characteristics



Internal Circuit:



Package Outline (Unit: mm):





Date	Revision	Notes
09/03/2024	01	Initial Release

Announcements

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The datasheet with “REV.” + “Arabic numerals” is based on engineering data for initial reference purpose only.

The released datasheet would be issued with “REV.” + “alphabet characters”.